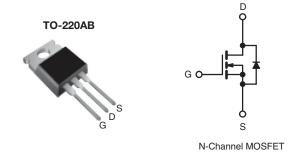


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 1.4				
Q _g (Max.) (nC)	24				
Q _{gs} (nC)	6.3				
Q _{gd} (nC)	11				
Configuration	Single				



FEATURES

• Low Gate Charge Qq Results in Simple Drive



- Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed power Switching

TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half Bridge
- Full Bridge

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF830APbF
	SiHF830A-E3
SnPb	IRF830A
	SiHF830A

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	.,	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Duais Current	V -140 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		5.0	A	
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	3.2		
Pulsed Drain Current ^a			I _{DM}	20		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	230	mJ	
Repetitive Avalanche Current ^a			I _{AR}	5.0	А	
Repetitive Avalanche Energy ^a			E _{AR}	7.4	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	74	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.3	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 18 mH, R_g = 25 Ω , I_{AS} = 5.0 A (see fig. 12). c. I_{SD} \leq 5.0 A, dI/dt \leq 370 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.7			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		<u>.</u>					
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.60	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.5	V
Gate-Source Leakage	I_{GSS}	\	$I_{GS} = \pm 30 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		500 V, V _{GS} = 0 V , V _{GS} = 0 V, T _J = 125 °C	-	-	25 250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.0 A ^b	-	-	1.4	Ω
Forward Transconductance	9 _{fs}	+	50 V, I _D = 3.0 A ^b	2.8	-	-	S
Dynamic						•	
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	620	-	
Output Capacitance	C _{oss}	1	V _{DS} = 25 V,	-	93	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	f = 1.0 MHz, see fig. 5		4.3	-	~F
Output Capacitance	C _{oss}	V _{GS} = 0 V; V	V _{GS} = 0 V; V _{DS} = 1.0 V, f = 1.0 MHz		886		pF -
Output Capacitance	C _{oss}	V _{GS} = 0 V; V _E	V _{GS} = 0 V; V _{DS} = 400 V, f = 1.0 MHz		27		
Effective Output Capacitance	C _{oss} eff.	$V_{GS} = 0 V;$	V _{GS} = 0 V; V _{DS} = 0 V to 400 V ^c		39		
Total Gate Charge	Q_g			-	-	24	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V			-	6.3	nC
Gate-Drain Charge	Q _{gd}		see fig. 6 and 13 ^b	-	-	11	1
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	$V_{DD} =$	V _{DD} = 250 V, I _D = 5.0 A,		21	-	
Turn-Off Delay Time	t _{d(off)}	$R_g = 14 \Omega$, $R_D = 49 \Omega$, see fig. 10^b		-	21	-	ns -
Fall Time	t _f			-	15	-	
Drain-Source Body Diode Characteristi	cs	·					
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	20	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 5.0 A, V _{GS} = 0 V ^b		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.0 A, dl/dt = 100 A/μs ^b		-	430	650	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.62	2.4	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				412)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

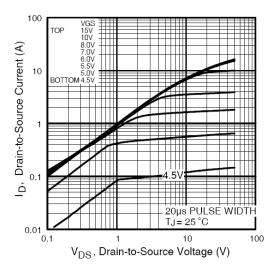


Fig. 1 - Typical Output Characteristics

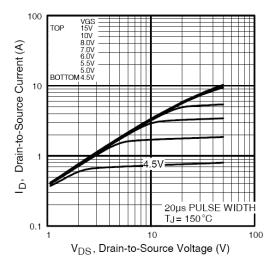


Fig. 2 - Typical Output Characteristics

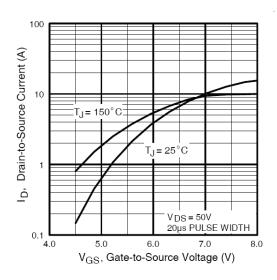


Fig. 3 - Typical Transfer Characteristics

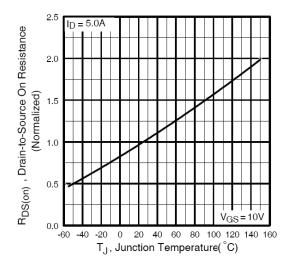


Fig. 4 - Normalized On-Resistance vs. Temperature



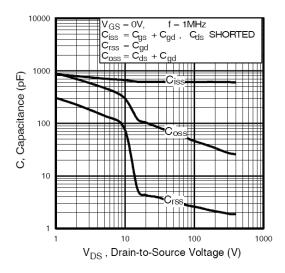


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

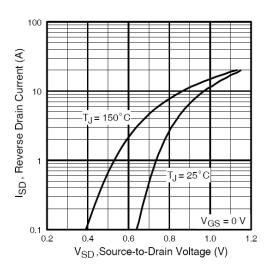


Fig. 7 - Typical Source-Drain Diode Forward Voltage

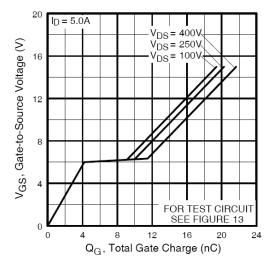


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

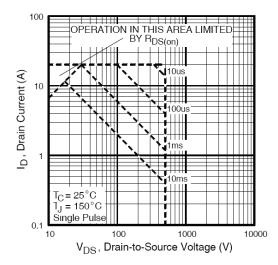


Fig. 8 - Maximum Safe Operating Area



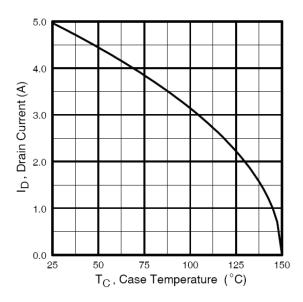


Fig. 9 - Maximum Drain Current vs. Case Temperature

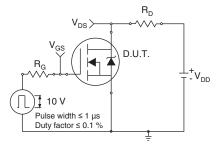


Fig. 10a - Switching Time Test Circuit

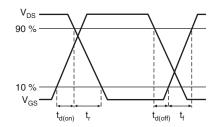


Fig. 10b - Switching Time Waveforms

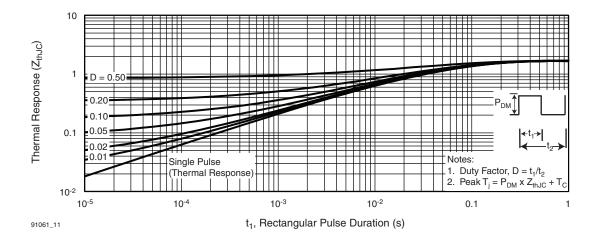


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



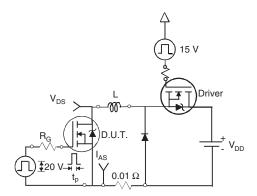


Fig. 12a - Unclamped Inductive Test Circuit

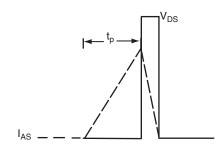


Fig. 12b - Unclamped Inductive Waveforms

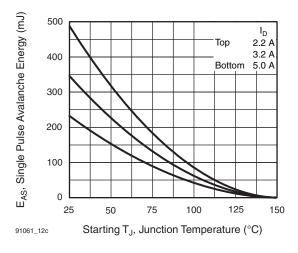


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

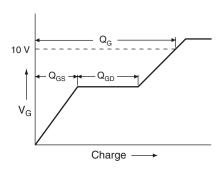


Fig. 12d - Basic Gate Charge Waveform

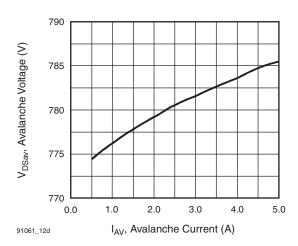


Fig. 13a - Typical Drain-to-Source Voltage vs. Avalanche Current

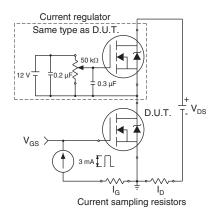
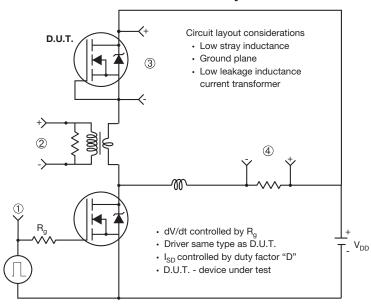


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



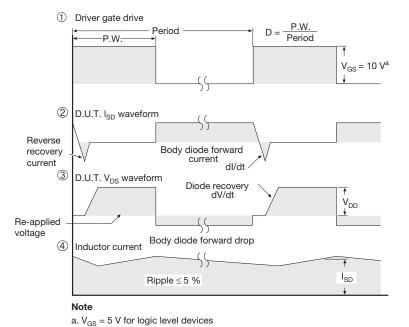


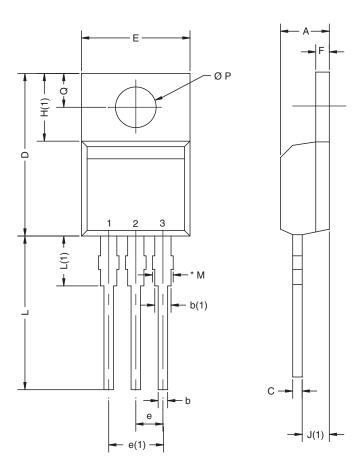
Fig. 14 - For N-Channel

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TO-220AB



	MILLIMETERS		INC	HES		
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X10-0416-Rev. M, 01-Nov-10						

DWG: 5471

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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